Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/743,327	BAE ET AL.
Examiner	Art Unit
Ganal C. Ray	2111

SEARCHED				
Class	Subclass	Date	Examiner	
710	100,300,3 01,313,31 5,1	12/5/2005	GCR	
235	454	12/5/2005	GCR	
369	18,24.01	12/5/2005	GCR	
369	30.03	12/5/2005	GCR	
369	47.1	12/5/2005	GCR	
369	44.31	12/5/2005	GCR	
711	111,112	12/5/2005	GCR	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
WEST: USPT, US OCR, EPO ABS, JPO ABS, DWPI, IBM TDB (see search history printouts)	12/5/2005	GCR
EAST: USPT (see search history printouts)	12/5/2005	GCR
NPL: IEEE Xplore (see search history printouts)	12/5/2005	GCR